Approaches for Achieving Broadband Achromatic Phase Shifts for Visible Nulling Coronagraphy

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ABSTRACT

Visible nulling coronagraphy is one of the few approaches to the direct detection and characterization of Jovian and Terrestrial exoplanets that works with segmented aperture telescopes. Jovian and Terrestrial planets require at least 10^{-9} and 10^{-10} image plane contrasts, respectively, within the spectral bandpass and thus require a nearly achromatic π -phase difference between the arms of the interferometer. An achromatic π -phase shift can be achieved by several techniques, including sequential angled thick glass plates of varying dispersive materials, distributed thin-film multilayer coatings, and techniques that leverage the polarization-dependent phase shift of total-internal reflections. Herein we describe two such techniques: sequential thick glass plates and Fresnel rhomb prisms. A viable technique must achieve the achromatic phase shift while simultaneously minimizing the intensity difference, chromatic beam spread and polarization variation between each arm. In this paper we describe the above techniques and report on efforts to design, model, fabricate, align the trades associated with each technique that will lead to an implementations of the most promising one in Goddard's Visible Nulling Coronagraph (VNC).

Keywords: coronagraphy, interferometry, achromatic phase shift

1. INTRODUCTION

The direct observation of Terrestrial planets in the visible bandwidth would allow for spectroscopic analysis to determine planetary composition, as well as the presence of water and the possibility to support life. To achieve direct detection, an instrument must be capable of high-contrast imaging, or differentiating the 10 orders-of-magnitude difference between the host star's diffracted light and that reflected by an orbiting Terrestrial planet. Furthermore, as more and more telescopes are being designed with segmented or sparse apertures, the direct-detection technique should be compatible with these architectures ^{1,2}.

The visible nulling coronagraph (VNC) is a direct detection technique that achieves all of these requirements. As shown in Figure 1, the VNC uses a symmetric Mach-Zehnder interferometer to suppress the starlight at an inner working angle (IWA) of $\sim 2\lambda/D$. A MEMS segmented deformable mirror (DM) in one arm of the interferometer provides wavefront control. When coupled with a fiber-bundle array, simultaneous amplitude and phase control is achieved with a single DM. Furthermore, the fiber-bundle array spatially filters the wavefront, relaxing high spatial-frequency wavefront requirements on the system. The segmented nature of the DM also makes the VNC compatible with segmented and sparse aperture systems.

As the name implies, the VNC operates in the visible bandwidth regime. In order to enable spectroscopy of the detected planets, the VNC must also accommodate broad bandwidths, ideally spanning the band from 400 nm to 700 nm. This implies that an *achromatic* phase shift of π radians must be introduced between the arms of the interferometer. Many techniques for achieving an achromatic phase shift have been developed for white-light interferometry. For example, a series of dispersive plates can be designed to balance the optical path length (OPL) at several wavelengths (similar to the design of achromatic doublet lenses)^{3,4,5}. Passing a beam through focus^{4,6}, or sequential reflections from mirrored surfaces can also introduce a phase shift⁶, at the cost of remapping the pupil of the optical system. Thin-film coatings can be used to achieve broadband performance of optics⁷. Recently, a series of Fresnel rhomb prisms, augmented by sub-wavelength gratings, have been used to achieve an achromatic phase shift in the infrared⁸.

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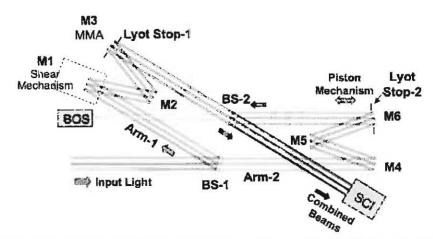


Figure 1 – Optical layout of the visible nulling coronagraph. Light enters from the telescope at the lower left and is split and recombined by two matched beamsplitters. Light reflecting off the 1st beamsplitter traverses two flats (M1 and M2) and reflects off a MEMS hex-packed segmented deformable mirror. This light both reflects and transmits through the 2nd beamsplitter and is combined with the light reflecting off flats M4, M5 and M6. There are two output channels labeled as the bright object sensor (BOS) used for fine pointing and wavefront control, and the science (SCI) channel, where an in-focus image of star system without the starlight is collected.

While all of these techniques have been developed previously, none have to date achieved the extreme performance requirements for high-contrast imaging at broadband, visible wavelengths. We report here recent successes in two separate designs to achieve a broadband visible achromatic π -phase shift for the VNC.

2. REQUIREMENTS OF ACHROMATIC PHASE SHIFTER

2.1 Contrast Dependence on Wavefront Error

The achievable contrast of the VNC depends on a number of instrumental properties and ultimately determines several performance requirements on the achromatic phase shifter (APS). Before discussing those requirements, however, it is illustrative to discuss the dependence of contrast on something more straightforward: the difference in the wavefront error between the arms of the interferometer (for a more detailed discussion of the operation of the VNC, the reader is directed to references 1 and 9).

The noise-free image irradiances in the bright and dark focal planes of the VNC are given by

$$I_{B}(\theta) = \frac{1}{2}I_{1}PSF_{0}(\theta) + \frac{1}{2}PSF_{\phi}(\theta) + \sqrt{I_{1}I_{2}}\operatorname{Re}\left\{ASF_{0}(\theta)ASF_{\phi}^{*}(\theta)\right\}$$

$$I_{D}(\theta) = \frac{1}{2}I_{1}PSF_{0}(\theta) + \frac{1}{2}PSF_{\phi}(\theta) - \sqrt{I_{1}I_{2}}\operatorname{Re}\left\{ASF_{0}(\theta)ASF_{\phi}^{*}(\theta)\right\}^{\frac{1}{2}}$$

$$(1)$$

where $I_B(\theta)$ and $I_D(\theta)$ represent the bright and dark channel output images, respectively, θ is the angular variable representing the focal plane projected on the sky, I_I and I_2 are the integrated intensities in each arm of the interferometer such that $I_I + I_2 = I_{star}$, $ASF_\theta(\theta)$ is the unaberrated, diffraction-limited complex amplitude spread function, ASF_ϕ is the aberrated (phase & amplitude) complex amplitude spread function and PSF_ϕ are the point spread functions given by

$$PSF_{0}(\theta) = ASF_{0}(\theta) ASF_{0}^{*}(\theta)$$

$$PSF_{0}(\theta) = ASF_{0}(\theta) ASF_{0}^{*}(\theta)$$
(2)

All of the phase and amplitude aberrations can be ascribed to one arm or the other of the interferometer without loss of generality since it is only the difference between the arms that matters.

Using the small angle approximation for the phase error of $e^{i\phi} \approx 1 + i\phi$, we can expand the dark channel equation for $I_D(\theta)$, which leads to the following expression for image-plane contrast:

$$C = \frac{I_D}{I_{star}} \approx \left(\frac{\pi W_0}{\lambda}\right)^2 PSF_0(\theta - \theta_0), \tag{3}$$

where θ_0 is the location of the planet and W_0 is the amplitude of the wavefront error at the spatial frequency that corresponds to that location in the image plane. If the mean wavefront error is zero (equivalent to the piston difference between the interferometer arms being zero) then the average contrast is

$$\langle C \rangle \approx \left(\frac{\pi W_0}{\lambda}\right)^2$$
 (4)

The brightness of speckles is exponentially distributed such that its mean is equal to the standard deviation of its intensity. Since we desire to set the requirements for the VNC based on high-confidence statistics we require

$$\langle C \rangle + 3\sigma_{\langle C \rangle} = 4 \langle C \rangle \le C_{Flight}$$
 (5)

where C_{Flight} is the flight requirement contrast limit. This insures that the flight contrast limit will be met better than 99% of the time. Solving Eq. (4) for the wavefront error and computing the RMS value gives

$$\sigma_{W} \approx \frac{1}{\sqrt{2}} \frac{\lambda}{\pi} \sqrt{\langle C \rangle}$$
 (6)

per spatial frequency.

For the lab VNC operating at a contrast of $C = 10^{-8}$ at $\lambda = 633$ nm requires $\sigma_W \approx 0.014$ nm per spatial frequency. The overall RMS wavefront error (WFE) is obtained by integrating σ_W over all spatial frequencies of interest. Spatial frequencies of interest are limited for the VNC to what is controllable by the segmented deformable mirror. The deformable mirror has 163 active segments, each with 3 control degrees of freedom (DOF), for a total of 489 control DOF in all. To achieve contrast of 10^{-8} with 489 DOF at $\lambda = 633$ nm requires $\sigma_W \leq 0.247$ nm. This is the requirement on the RMS difference of the wavefront error between the two arms of the interferometer, if all other error sources are considered negligible.

2.2 Contrast Dependence on the APS

Of course, there are other error sources that are non-negligible, including intensity variations due to coating imperfections, polarization variations and errors due to a finite spectral bandpass. For each of these terms, an analysis similar to the one performed in Section 2.1 will yield requirements on how well the APS must control these error sources. We can re-express the bright- and dark-channel intensities from Eq. (1) in terms of the variance of each of the error terms:

$$I_{B}(\theta) = \frac{1}{1 + \frac{\pi^{4}}{8} |\theta|^{3}} \left\{ 1 - \left[\pi^{2} \left(\frac{\sigma_{W}}{\lambda} \right)^{2} + \frac{\sigma_{I}^{2}}{16} + \frac{\sigma_{\psi}^{2}}{4} + \frac{\pi^{2}}{48} \left(\frac{\Delta \lambda}{\lambda_{0}} \right)^{2} \right] \right\}$$

$$I_{D}(\theta) = \frac{1}{1 + \frac{\pi^{4}}{8} |\theta|^{3}} \left[\pi^{2} \left(\frac{\sigma_{W}}{\lambda} \right)^{2} + \frac{\sigma_{I}^{2}}{16} + \frac{\sigma_{\psi}^{2}}{4} + \frac{\pi^{2}}{48} \left(\frac{\Delta \lambda}{\lambda_{0}} \right)^{2} \right]$$
(7)

where σ_W is the RMS wavefront error as computed in Section 2.1, σ_I^2 is the variance of the fractional intensity difference between the arms of the interferometer, σ_{ψ}^2 is the variance of the difference in polarization-vector rotation between the arms in units of radians, $\Delta\lambda$ is the spectral bandwidth of the system, and we've made use of the asymptotic form of the PSF:

$$PSF(\theta) = \left[1 + \frac{\pi^4}{8} |\theta|^3\right]^{-1}.$$
 (8)

The last term in each expression in Eq. (7) is due to spectral leakage from the path length difference between the two arms of the interferometer. Ideally, the path length difference is half of the central wavelength, λ_0 , to yield a phase difference of $(2\pi/\lambda_0)OPL = \pi$ where OPL is the optical path length difference. At wavelengths different than λ_0 , the phase difference does not result in perfect destructive interference and light is leaked through, lowering the contrast. The primary role of the APS is to create an OPL such that the phase difference is constant as a function of the wavelength, effectively setting the fourth term of the expressions in Eq. (7) to zero.

Since some techniques for the APS employ a refractive element, it can introduce lateral chromatic color that is different in each arm of the VNC. Beams that shift differently as a function of wavelength in each arm create a mismatch in the output pupils, i.e. a shear. A Lyot stop masks out the edge of the pupil where the beams don't overlap, however it does interfere one beam against a slightly different part of the other beam. This yields a wavelength-dependent shear that leaks light through and lowers the contrast.

Assuming the electric field of the leaked light is given by

$$E = \frac{1}{2} \left[e^{i\phi(x)} - e^{i\phi(x-\Delta s)} \right] \tag{9}$$

where $\phi(x)$ and $\phi(x - \Delta s)$ are the phase error and the shifted phase error, respectively, then the focal-plane leakage term has the form

$$I = PSF_{\phi} \sin^2 \left(\pi \frac{\Delta s}{D} \theta \right) \approx \frac{1}{1 + \frac{\pi^4}{8} |\theta|^3} \left(\pi \frac{\Delta s}{D} \theta \right)^2$$
 (10)

where $\Delta s/D$ is the fractional beam shift due to the differential dispersion. Adding this term to the sum of error terms in Eq. (7) gives

$$I_{B}(\theta) = \frac{1}{1 + \frac{\pi^{4}}{8} |\theta|^{3}} \left\{ 1 - \left[\pi^{2} \left(\frac{\sigma_{W}}{\lambda} \right)^{2} + \frac{\sigma_{I}^{2}}{16} + \frac{\sigma_{\Psi}^{2}}{4} + \frac{\pi^{2}}{48} \left(\frac{\Delta \lambda}{\lambda_{0}} \right)^{2} + \left(\pi \frac{\Delta s}{D} \theta \right)^{2} \right] \right\}$$

$$I_{D}(\theta) = \frac{1}{1 + \frac{\pi^{4}}{8} |\theta|^{3}} \left[\pi^{2} \left(\frac{\sigma_{W}}{\lambda} \right)^{2} + \frac{\sigma_{I}^{2}}{16} + \frac{\sigma_{\Psi}^{2}}{4} + \frac{\pi^{2}}{48} \left(\frac{\Delta \lambda}{\lambda_{0}} \right)^{2} + \left(\pi \frac{\Delta s}{D} \theta \right)^{2} \right]$$

$$(11)$$

Using Eq. (11), along with the requirement that the contrast in Eq. (3) be 10^{-8} , performance requirements of the APS with respect to each of the error terms can be generated. These performance requirements are summarized in Table 1 assuming D = 1 cm, $\lambda = 633$ nm and $\theta = 2\lambda/D$.

Table 1 - Performance Requirements of the APS

Requirement	Value	Units
RMS Phase Shift	< 0.00045	Radians
RMS Intensity Difference	< 0.0005	Percent
RMS Polarization Rotation Difference	< 0.00017	Radians
Differential Dispersion Beam Shift	< 2.0	Microns

3. GLASS PLATE APS

3.1 Theory

The theory behind the dispersive element achromatic phase shifter is closely related to the design of achromatic lenses. By balancing the wavelength-dependent indexes of refraction of different materials, the optical path length through the element can be made almost uniform for multiple wavelengths. Generally speaking, more dispersive elements are required to correct a broader range of wavelengths. For example, an achromatic lens is usually a doublet that corrects the optical path at two design wavelengths, while an apochromatic lens is usually a triplet and corrects the optical path for three design wavelengths.

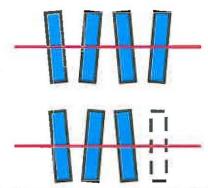


Figure 2 – Example arrangement of glass plates. Each plate is tilted by 2.5° to prevent ghost reflections from propagating through the system. The dashed outline indicates that one arm of the interferometer may include an additional airspace in order to achieve the achromatic phase shift.

For the VNC, the dispersive elements have no optical power, which is to say they are simple glass plates with parallel surfaces. However, to prevent ghost reflections off each of the plate facets from propagating through the system, the windows are oriented at an angle to each other of approximately 2.5°. Figure 2 shows an example layout for the glass plates. For such an arrangement, the optical path length through the plates is given by

$$OPL(\lambda) = \sum_{j=1}^{N_{plate}} \frac{t_j n_j(\lambda)}{\cos \alpha_j'(\lambda)},$$
(12)

where t_j is the thickness of the j^{th} plate, $\alpha'_j(\lambda)$ is the angle of refraction at the j^{th} plate and $n_j(\lambda)$ is the index of refraction of the j^{th} plate. The phase shift between the arms of the interferometer is then given by

$$\Delta\Phi(\lambda) = \frac{2\pi}{\lambda} \Big[OPL(\lambda)_{arm_1} - OPL(\lambda)_{arm_2} \Big]. \tag{13}$$

Arranging the plates in an angled configuration, however, introduces several other effects on the optical beam that must be mitigated. At non-normal incidence, the beam will refract as it enters each glass plate, and again as it exits. After passing through several glass plates, the beam will have dispersed laterally in one dimension as a function of

wavelength, as demonstrated in Figure 3. The beam displacement when passing through a series of glass plates at non-normal incidence is give by

$$D(\lambda) = \sum_{j=1}^{N_{plane}} t_j \left[1 - \frac{\cos \alpha_j}{n_j(\lambda) \cos \alpha_j'(\lambda)} \right]$$
 (14)

where α_j is the angle of incidence at the j^{th} plate. As discussed in Section 2, the differential dispersed beam width between the arms of the interferometer, $\Delta D = |D(\lambda)_{arm1} - D(\lambda)_{arm2}|$, must be less than 2 μ m.

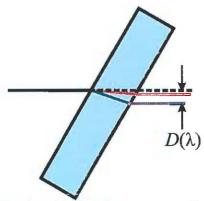


Figure 3 – Beam displacement when passing through a glass plate at non-normal incidence. The total difference in the beam displacement between the two arms must be small enough that when re-combined, the two beams interfere with the same regions.

Also, it is well known that a linearly polarized beam passing through a plate at non-normal incidence will undergo a slight rotation of its polarization angle relative to plane of incidence ¹⁰. If $P_i(\lambda)$ is the initial angle between the plane of polarization and the plane of incidence, then after transmitting through the glass plates, the angle will be

$$P_{o}(\lambda) = P_{i}(\lambda) \prod_{j=1}^{N_{plotter}} \cos \left[\alpha_{j} - \alpha'_{j}(\lambda)\right] \cos \left[\alpha'(\lambda)_{j} - \alpha_{j}\right], \tag{15}$$

assuming a small-angle approximation, and where the first cosine term corresponds to the beam entering a particular glass plate and the second cosine term corresponds to the beam exiting that same plate. The standard deviation of the differential change in polarization between the arms of the interferometer, $\Delta P_o(\lambda) = |P_o(\lambda)_{arm1} - P_o(\lambda)_{arm2}|$, must be less than 0.00017 radians.

Finally, at each air-glass interface, the beam intensity will be reduced by Fresnel reflection and transmission losses. Through a single arm of the interferometer, the Fresnel intensity transmission coefficient is given by

$$T(\lambda) = \prod_{j=1}^{N_{planer}} \left\{ 1 - \frac{\sin^2 \left[\alpha_j(\lambda) - \alpha'_j(\lambda) \right]}{\sin^2 \left[\alpha_j(\lambda) + \alpha'_j(\lambda) \right]} \right\} \left\{ 1 - \frac{\sin^2 \left[\alpha'_j(\lambda) - \alpha_j(\lambda) \right]}{\sin^2 \left[\alpha'_j(\lambda) + \alpha_j(\lambda) \right]} \right\}, \tag{16}$$

where the first term in braces corresponds to the beam entering a particular glass plate and the second term in braces corresponds to the beam exiting the same plate. The standard deviation of the differential change in intensity between the arms of the interferometer, $\Delta T(\lambda) = |T(\lambda)_{arm1} - T(\lambda)_{arm2}|$, must be less than 0.0005 %.

3.2 Design Procedure

The design of the glass-plate APS is one of optimization: what selection of plate materials and thicknesses minimizes the differential lateral dispersion, transmitted intensity and change in polarization, while achieving the achromatic phase shift? The optimization procedure is complicated by the fact that one set of variables, the plate materials, is discrete

while the other set, plate thicknesses, is continuous. We used an in-house global search routine that generates configurations by selecting glass materials from a database. These configurations are optimized by following several trajectories through the search-space using a recursive branching structure. For each configuration that is tested, the glass plate thicknesses are optimized by a constrained nonlinear optimization routine. We found this in-house routine to be significantly more efficient than a traditional global search algorithm such as simulated annealing.

The error metric that is evaluated by the optimization routine is a weighted sum of components for each of the conditions presented in Section 3.1. The error metric components for the phase shift, transmitted intensity difference, and differential change in polarization are the mean-squared-errors, given by

$$E_{OPL} = \sum_{\lambda} \left[\Delta \Phi(\lambda) - \pi \right]^2 , \qquad (17)$$

$$E_{T} = \sum_{\lambda} \left[T(\lambda)_{arm1} - T(\lambda)_{arm2} \right]^{2}, \qquad (18)$$

and

$$E_{P} = \sum_{\lambda} \left[P_{o}(\lambda)_{arm1} - P_{o}(\lambda)_{arm2} \right]^{2} \tag{19}$$

The error metric component for the lateral dispersion component is the standard deviation of the differential lateral dispersion, since mean errors can be removed through re-alignment of the two arms of the interferometer. The error metric component is given by

$$E_D = \sqrt{\frac{1}{N_{\lambda}} \sum_{\lambda} \left[\Delta D(\lambda) - \overline{\Delta D(\lambda)} \right]^2} , \qquad (20)$$

where the overbar denotes computing the mean value of the quantity.

The total error metric to be minimized by the global search routine is a weighted sum of these components:

$$E = \gamma_1 E_{OPL} + \gamma_2 E_D + \gamma_3 E_T + \gamma_4 E_P \tag{21}$$

where the relative weights allow us to emphasize certain components over the others, if needed. Analytic derivatives of E with respect to the glass plate thicknesses are easily computed to facilitate the nonlinear optimization portion of the search.

3.3 Design Results

Initially, a large glass database was used to generate the random configurations used in the global search algorithm, and several solutions were found. However, to improve manufacturability of the glass plates, a second round of optimizations was performed with a restricted, "preferred" database of commonly used glasses that are easy to work with. Table 2 shows the location, material and thickness of each plate.

Table 2 - Glass Plate Achromatic Phase Shifter Solution

Location	Material	Thickness (mm)
Arm 1	Ohara S-TIM25	3.835
Arm 1	Ohara S-BSM28	5.199
Arm 1	Ohara S-TIH4	9.395
Arm 2	Ohara S-BSM28	3.519
Arm 2	Ohara S-TIH1	14.780
Arm 2	Vacuum	0.240

This solution uses five individual plates and four distinct materials and provides an achromatic phase shift over the bandwidth between 530 nm and 730 nm. Figure 4 - Figure 7 show the phase shift error, differential lateral dispersion, differential transmitted intensity, and differential change in polarization, respectively, as functions of wavelength. Table 3 summarizes the performance metrics of the solution.

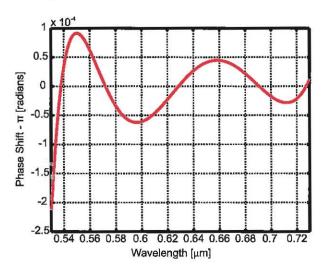


Figure 4 – The error in the phase shift, $[\Phi_{arm1}(\lambda) - \Phi_{arm2}(\lambda)] - \pi$. The mean error is -1.44×10⁻⁹ radians with a standard deviation of 4.70×10⁻⁵ radians.

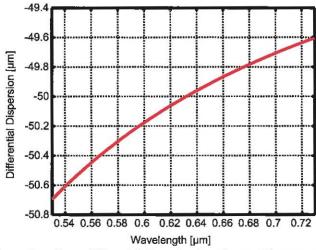


Figure 5 – The beam shear due to differential dispersion in each arm. The mean error is -50.06 μ m, which can be removed through re-alignment. The standard deviation of the error is 0.31 μ m.

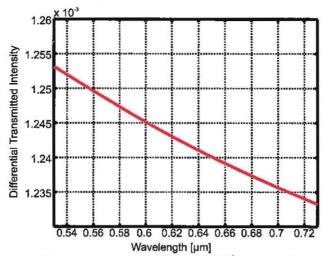


Figure 6 – The differential transmitted intensity. The mean value is 1.24×10⁻³ percent, which can be removed by balancing the average intensity in each arm of the interferometer. The standard deviation is 5.78×10⁻⁶ percent.

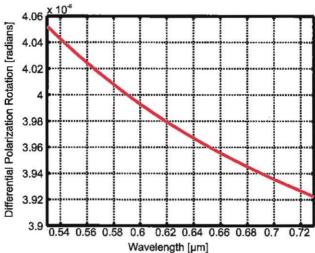


Figure 7 – The differential rotation of the polarization vector between the arms. The mean value is 3.98×10^{-6} radians and the standard deviation is 3.72×10^{-8} radians.

Table 3 - Performance results for the glass-plate APS solution presented in Table 2.

Quantity	Mean Error	Standard Deviation
Phase Shift	-1.44×10 ⁻⁹ radians	4.70×10 ⁻⁵ radians
Beam Shear	-50.06 μm	0.31 μm
Differential Intensity	1.24×10 ⁻³ %	5.78×10 ⁻⁶ %
Differential Rotation of the Polarization Vector	3.98×10 ⁻⁶ radians	3.72×10 ⁻⁸ radians

3.4 Manufacturability & Alignment

While this solution meets all of the necessary performance requirements, it proves to be infeasible from a manufacturing and alignment perspective. Material imperfections play a big role in terms of striae, or non-uniformities in the index of refraction of the glass. It is possible to obtain high-quality melts of some glass materials that would meet the stringent zero-tolerance of the VNC APS. However, for the glasses listed in Table 2, such quality is not guaranteed.

Polishing the glass plates poses another challenge. The thickness of the glass plate is the dominant contributor to the OPL through the plate, and must be controlled to better than $\pm 25 \ \mu m$. While it is possible to achieve such

accuracy with modern polishing techniques, it forces other tolerances such as surface flatness, surface roughness, and surface quality (i.e. scratch-dig) to be relaxed. Ultimately, the polishing of each plate is a best-effort attempt, with no guarantee that the requirements will be met. It is possible that some error in the plate thickness can be compensated by adjustments in the angle of the glass plate. Preliminary tolerancing of the alignment of the plates, however, shows that the angular alignment needs to be achieved with arc-second accuracy in the lab.

4. THIN-FILM FRESNEL RHOMB APS

4.1 Theory

A second technique of achieving the APS uses a pair of Fresnel rhomb prisms in each arm of the interferometer and was first reported by Mawet, et. al., for use in the infrared regime⁸. The concept leverages the polarization-dependent phase shift that occurs when a beam undergoes total internal reflection (TIR). A schematic of the device is shown in Figure 8. The phase shift between the s and p polarization states for a single TIR is given by

$$\Delta \Phi_{s-p}(\lambda) = 2 \arctan \left[\frac{\sqrt{\sin^2 \alpha - n_{te}^2(\lambda)}}{n_{te}^2(\lambda) \cos \alpha} \right] - 2 \arctan \left[\frac{\sqrt{\sin^2 \alpha - n_{te}^2(\lambda)}}{\cos \alpha} \right]$$
(22)

where α is the angle of incidence at the interface, and $n_t(\lambda)$ is the ratio of the emergent and incident indexes of refraction:



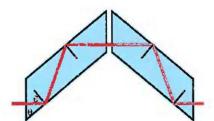


Figure 8 – A diagram of the Fresnel rhomb APS. The beam undergoes 4 total-internal reflections (TIR). At each TIR, a polarization-dependent retardance is introduced in the beam. The acute prism angle determines the angle of incidence at the TIR interface.

The phase shift as a function of angle-of-incidence is shown in Figure 9 for TIR at a fused-silica/air interface for several wavelengths. There are two aspects to note: First, the phase shift is nearly achromatic for this selection of materials, though not enough to meet the VNC's requirements. Second, the maximum phase shift achieved at an angle of incidence of 53° is only 0.74 radians. Even after the four TIR bounces in the device shown in Figure 8, the total phase shift is still less than π .

Mawet, et. al., used a subwavelength grating at the TIR interfaces to augment the phase shift in the infrared, achieving not only the necessary phase shift magnitude, but also achromaticity. They also explored the use of thin-film coatings at the TIR interfaces – a technique we optimize here for visible wavelengths. If r is the amplitude reflection coefficient of the thin-film coating, then the phase of the reflected beam is $\arctan(r)$. The polarization-dependent phase shift is then given by

$$\Delta\Phi_{s-p}(\lambda) = \arctan[r_s(\lambda)] - \arctan[r_p(\lambda)]$$
(24)

where r_s is the amplitude reflection coefficient for s-polarization and r_p is the amplitude reflection coefficient for p-polarization.

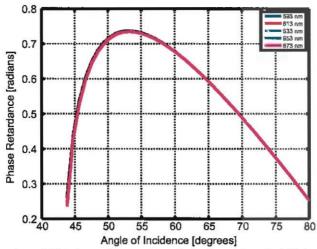


Figure 9 – The phase shift between the s- and p-polarization states at total internal reflections. The phase shift is nearly achromatic, and has a peak at 53° of 0.74 radians.

Through proper selection of the substrate material, angle-of-incidence, coating layer thickness, coating layer material, and the number of coating layers, one can tune the polarization-dependent phase shift to be achromatic and equal to π . A second device in the opposite arm of the interferometer, rotated by 90°, introduces the phase shift in the opposite polarization state. For example, in the first arm of the interferometer, the p-polarization state is retarded by π radians relative to the s-polarization state. Conversely, in the second arm of the interferometer, the s-polarization state is retarded by π radians relative to the p-polarization state. Thus, when the beams are recombined, each polarization state destructively interferes to produce a null.

4.2 Design Process

The design of the Fresnel rhomb prisms was performed similarly to the glass-plate APS. A global search routine was run over the free-variables of angle-of-incidence, coating layer material, and coating layer thickness to achieve the requirements. The substrate was chosen to be Schott LITHOSIL, as high-quality melts with no striae or inclusions can be obtained. Initially, the coating was constrained to have only two layers for simplicity. The global search routine generated coating configurations by drawing materials from a pre-specified database, and then optimized the angle-of-incidence and each layer thickness by constrained nonlinear optimization.

Unlike the glass plate APS, the error metric that was optimized consists of only a single term related to the phase shift. This simplification is due to several reasons. First, in the nominal design of the APS, the beam does not undergo refraction anywhere, so there is no beam shear due to differential dispersion. Furthermore, since all reflections are TIR, the Fresnel rhombs provide 100% throughput in each arm (ignoring absorptive effects of the substrates, which should be equivalent in each arm anyway). Also due to each reflection being TIR, there is no rotation of the polarization vector at each interface; the polarization state of the beam is preserved.

The error metric minimized by the global search routine is just

$$E = \sum_{\lambda} \Delta \Phi_s^2(\lambda) + \sum_{\lambda} \Delta \Phi_p^2(\lambda)$$
 (25)

where $\Delta\Phi_s$ and $\Delta\Phi_p$ are the phase differences between the arms of the interferometer for s- and p-polarization, respectively.

4.3 Design Results

Several solutions were found that achieved the VNC's requirements; the one with the best performance was selected for fabrication. Figure 10 shows a schematic of a single prism, including the coating prescription for each surface. All four prisms are identical. Figure 11 shows the phase shift performance for each polarization state over the 40-nm

bandwidth centered about 632.8 nm. Table 4 summarizes the design & performance parameters of the Fresnel rhomb APS.

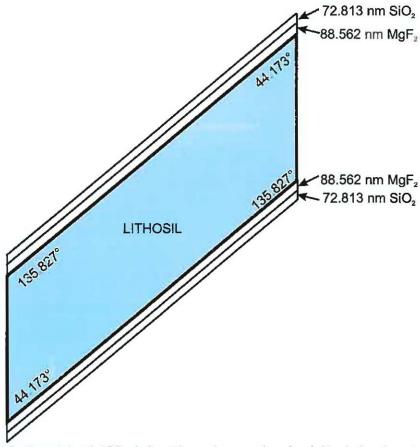


Figure 10 – The Fresnel rhomb APS solution. The coating on each surface is identical, and consists of just two layers. All four prisms are identical.

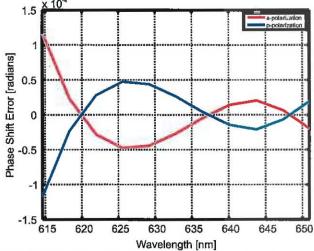


Figure 11 – The phase shift error, $[\Phi_{arm1}(\lambda) - \Phi_{arm2}(\lambda)] - \pi$, in each polarization state. The mean error for s-polarization is 4.14×10^{-7} radians with a standard deviation of 4.35×10^{-5} radians. For p-polarization, the mean error is -1.24×10^{-6} radians with a standard deviation of 4.35×10^{-5} radians.

Table 4 – Fresnel rhomb prism APS design parameters and performance values.

Parameter:	Value:
Substrate Material	Schott LITHOSIL
Prism Acute Angle	44.173°
Prism Obtuse Angle	135.827°
Coating Layer 1 Material	MgF ₂
Coating Layer 1 Thickness	88.562 nm
Coating Layer 2 Material	SiO ₂
Coating Layer 2 Thickness	72.813 nm
s-Polarization Mean Phase- shift Error	4.14×10 ⁻⁷ radians
s-Polarization Phase-shift Error Standard Deviation	4.35×10 ⁻⁵ radians
<i>p</i> -Polarization Mean Phase-shift Error	-1.24×10 ⁻⁶ radians
p-Polarization Phase-shift Error Standard Deviation	4.35×10 ⁻⁵ radians

4.4 Discussion

From a manufacturing perspective, the Fresnel rhomb APS appears to be more feasible than the glass plate APS. Since all four prisms are identical in design, they can be polished as a single block and later diced, reducing the variation in polishing errors of the prism angle. The prisms can also be coated as a group, reducing variation in coating layer thickness.

Tolerances on both the prism angle and layer thicknesses are within standard manufacturing precision. The prism angle (which determines the angle-of-incidence for the TIR reflections) is actually a fairly loose tolerance. Once the prisms are manufactured, the prism angle can be measured to arc-second accuracy and the coating prescription can be re-optimized to accommodate. Coating layers can routinely be controlled during deposition with nanometer accuracy.

4.5 Variations to the Design

We are currently exploring a variation to the design of the Fresnel rhomb APS, as well as running a more detailed tolerancing analysis to determine the manufacturability of the device. The design variation is required to mitigate ghost reflections between the prism pairs in each arm. A wedge angle is added to the input and output facets of each prism, as shown in Figure 12. The biggest impact this has on performance is that it re-introduces beam shear due to differential dispersion since the beams now refract upon entering and exiting each prism. Furthermore, since the device in each arm is rotated by 90° with respect to its counterpart, the beams shear in orthogonal dimensions. We are still exploring the impact of this on the APS performance.

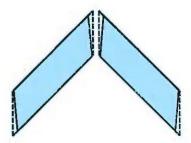


Figure 12 - Fresnel rhomb APS with wedged interfaces to direct ghost reflections out of the system.

A Monte Carlo study is also being performed on the manufacturing process to determine the potential yield of devices that will meet the VNC's requirements. Using the baseline design, typical polishing errors are added to the

prism angle and the coating prescription is re-optimized to achieve the desired phase shift. Random manufacturing errors are then added to the coating layer thicknesses to determine the final performance of the device. The results of this study are not yet available.

5. CONCLUSION

We report here on two new designs to achieve an achromatic phase shift for the visible nulling coronagraph. The APS is required to achieve high-contrast, broadband direct detection of exoplanets. The first design uses a series of dispersive glass plates to achieve a π -phase shift across the band between 530 nm - 730 nm. The RMS error of the achieved phase shift is 4.7×10^{-5} radians. Differential intensity, lateral beam dispersion, differential polarization rotation and ghost images are also minimized. Ultimately, the glass plate solution proved too difficult to manufacture and align in the lab VNC.

The second design uses Fresnel rhomb prisms and leverages the polarization-dependent retardance that occurs at total-internal reflection. Thin film coatings on the TIR interfaces are used to augment the retardance to achieve the desired phase shift as well as achromaticity. The optimized solution uses four LITHOSIL-substrate prisms with two-layer coatings of SiO₂ on MgF₂ to achieve the phase shift. Two prisms are used in each arm, with one arm rotated by 90° to achieve the complementary retardance.

The Fresnel rhomb APS appears to be more easily manufactured and aligned than the glass plate APS. Further study is being performed to determine tolerances on the prism angles and coating prescription.

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Approaches for Achieving Broadband Achromatic Phase Shifts for Visible Nulling Coronagraphy

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Valide nulling coronagraphy is one of the few applicables to the direct detacton and characterization of Jovian and Turnicial ecopiancis that works with segmented aperture tolescopes. Jovian and Tame-trial planets in require a nearly achromatic m-phase difference between the arms of the interferometer. An achromatic m-phase shift can be achieved by several techniques, including sequential anguest thick glass plates of verying dispersive materials, distributed thin-firm multilayer coefings, or techniques that inversage the potentization-dependent phase shift of total-inherest interections. Herein the describe two implementations of such techniques materials and achieves the achromatic phase shift white simultaneously information that difference, prometic beam appread and potanziation winders have been seen that the phase when the phase we describe the above implementations and report on the trades associated with each technique that will lead to an implementation of the most promising on the Golddard's Valide, Companying (VNC).

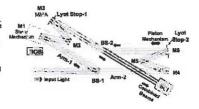
Introduction

The direct observation of Tierrestrial planets in the visible bandwidth would allow for spectroscopic analysis to determine planetary composition, as well as the presence of matrix and the possibility to support title. To archieve circat detaction, and returnment must be capable of high-contrast unegrop, or differentiating the 10 ordinar-of-magnitude difference believe the host starts diffracted light and that reflected by an orbiting Terrestrial planets. Furthermore, as more and more telescopes are being designed with segmentator sparse apertures, the direct-defection technique should be compositive with these architectures.

The visible multing coronagraph (VNC) is a direct detection bedinique that anchieves at of these requirements. As aboven in Figure 1, the VNC uses a symmetrix Moch-Zehnderinterferomount to supervise the startight at an innerworking angle (fWA) of +2A/D, which is it the wavelength and D is the beam it america. A MEMS segments ideformable mirror (OM) in one arm of the interferomets, provides wavefront control. Which coupled with a tiber-bundle array simultaneous empilitude and phase control in achieved with a single DM. Furthermore, the fiber bundle array spatially filters the wavefront, networking high spatial-frequency weil efront requirements on the system. The segmented nature of the DM also makes the VNC consustible with segmented- and sparse-sporture systems.

As the name implies, the VNC operates in the visible bandwich regime. In order to enable spectroscopy of the delicated planets, the VNC must also eccommodate broad bendwidths, kitally spanning the band from 400 nm to 700 nm. This broad band iddit implies that an achromatic nulling phase with (of mindiane) must be introduced between the arms of the interferometrs. Many techniques for achieving as a schromatic phase with histories described by the interferometry. For example, a serius of dispansive planes can be designed to batance the optical just hingh (OPL) at several wavelengths (similar to the design of schromatic doublet lenses). Plassing a beam through focus, or sequential reflections from mirrored can after introduces a phase; with, at the cost of re-orienting the pupil of the optical system. Thin-film coatings can be designed to be considered to the optical system.

Figure 1 - Optical layout of the visible nulling coronagraph. Light enters from the bisecope at the lower left and is split and nonembed by two matched bearmsyllates. Uptit reflecting off the 1st bearmsyllater the unces also fasts. With and M2) and reflects of a MEM'S have peached segmented deformable mirror. This light both reflects and transmiss hrough the 2nd beamsyllater and is combined with the tight reflecting off filer. M4, M5 and M6, This is are two outgut channels labelled as the hight object sensor (80:03) used for fine pointing and wavefront control, and the stripens (90:10) channel, where an in-force image of all systems (90:10) and the stripens (90:10) channel, where an in-force image of the system without the startight is collected.



Glass-Plate APS

The theory behind the dispersive element achromatic phase shifter is closely related to the design of achromatic lenses. By belancing the wavelength-dependent indices of retraction of different materials, the optical path length through the element can be made almost uniform for multiple was blancing. Generally energing the comments are required to control a broader range of wavelengths.

For the VNC, the dispertive ifements have no optical power, which is to say they are simple glass plains his to have perallel surfaces. However, to prevent ghost reflections off each of the plate fewers from propagating through the system, the windows are oriented at an angle to each other of approximately 5°. Figure 2 shows an example layout for the glass plates. For such an arrangement, the optical path length through the plates is

 $OPL(\lambda) = \sum_{j=1}^{N} \frac{c_j r_j(\lambda)}{\cos \alpha_j^2(\lambda)}$

where t is the thickness of the figure, rith) is the angle of refraction at the figure and rith) is the index of refraction of the figure. The phase shift

 $\Delta\Phi(\lambda) = \frac{2\pi}{\lambda} \left[OPL(\lambda)_{am1} - OPL(\lambda)_{am1} \right]$

Arranging the plates in an engled configuration, however, introduces several other effects on the optical beam that must be militated. At non-normal incidence, the beam will refract as it enters each glass plate, and again as it exits. After passing through as arrail glass plates, the beam will have dispersed laterally in one dimension as a function of wavelength. The beam displacement when passing through a series of glass plates at

 $B(\lambda) = \sum_{j=1}^{n} t_j \left[1 - \frac{\cos \alpha}{n_j(\lambda) \cos \alpha_j^*(\lambda)} \right]$

where \mathbf{q} is the ungle of incidence at the \mathbf{f}^* plate. The differential dispersed beamwidth between the arms of the interferometer $\Delta \mathbf{B} = [\mathbf{B}(\mathbf{A}_{i+1} - \mathbf{B}(\mathbf{A}_{i+1}), \mathbf{L}]$ must be less than $2 \, \mu \mathbf{n}$.

A linearly polerized plan persing through a plate at non-normal incidence will undergo a slight rotation of its polarization engle residue to the plane of incidence. If P/A) is the initial might between the plane of polarization and the plane of incidence, then after transmitting through the glaus of the polarization and the plane of incidence.

 $P_{\alpha}(\lambda) = P_{i}(\lambda) \prod_{j=1}^{n} \cos \left[\sigma_{i} - \sigma_{j}'(\lambda) \right] \cos \left[\sigma'(\lambda)_{i} - \sigma_{i} \right]$

essuming a small-angle of proximation. The standard deviation of the differential change in polarization between the arms of the interferonce of $\Delta P_{i}(\lambda) = |P_{i}(\lambda)|_{\infty}$, $\nabla P_{i}(\lambda)|_{\infty}$, $|P_{i}(\lambda)|_{\infty}$, which is less than 0.00017 radians.

At each eingless interface, the beam intensity will be reduced by Fresnel reflection and transmission losses. Through a suigle sum of the interferometer, the Fresnel Intentity transmission coefficient is given by

$$\mathbf{T}\left(\lambda\right) = \prod_{j=1}^{n_{\max}} \left\{1 - \frac{\sin^{3}\left[\alpha_{j}(\lambda) - \alpha_{j}^{*}(\lambda)\right]}{\sin^{3}\left[\alpha_{j}(\lambda) + \alpha_{j}^{*}(\lambda)\right]}\right\} \left\{1 - \frac{\sin^{2}\left[\alpha_{j}^{*}(\lambda) - \alpha_{j}(\lambda)\right]}{\sin^{3}\left[\alpha_{j}^{*}(\lambda) + \alpha_{j}(\lambda)\right]}\right\}$$

The standard deviation of the differential change in intensity between the arms of the interferometer, $\Delta T(\lambda) = \{T(\lambda), ..., -T(\lambda), ..., [must be less than notices.]\}$

Thin-Film Fresnel Rhomb APS

As round technique of achieving the APS use's a pair of Prished rhomb prisms in each arm of the interferometer and was first reported by Malest at N. for use in the laft used regime. The concept inversages the polarization-rispandent phase shift that occurs when a beam undergoes total internal reflection (TIR). A schematic of the device is shown in Figure 3. The phase shift between the sand protestation status for a single TIR to ginn by

$$\Delta \Phi_{z-y}\left(\lambda\right) = 2 \arctan \left[\frac{\sqrt{\sin^2\alpha \cdot n_w^2\left(\lambda\right)}}{n_w^2\left(\lambda\right)\cos\alpha}\right] - 2 \arctan \left[\frac{\sqrt{\sin^2\alpha \cdot n_w^2\left(\lambda\right)}}{\cos\alpha}\right]$$

viners q is the ancie of incidence at the interface, and ru(A) is the ratio of the emergent and incident indexes of refraction.

The phase shift as a function of angle-of-incidence is shown in Figure 4 for TIR at a fused-ellowish in first or several wavelengths. There are two expects to note: First, the phase shift is nearly achromatic for this selection of meterials, though not arough for the VNG to must performance requirements. Seconf, the maximum phase shift achieved at an angle of incidence of 63' is only 0.74 radians. Even after the four TIR bounce the tolk phase shift is still less than 17.

Ments of al., used a subveniously grating at the hill interfaces to summent the phase shift in the infrared, a histring not only the necessary phase shift magnitude, but also achromaticity. They also explored the use of thin-film costings at the TIR interfaces – a technique we optimize here for visible interelegation. If it is the amplitude reflection coefficient of the thin-film coating, then the phase of the reflected beam is arcter(r). The reflection the state of the state of the state of the reflected beam is arcter(r).

$$\Delta \Phi_{i-p}(\lambda) = \arctan[z_i(\lambda)] - \arctan[z_p(\lambda)]$$

where r, is the amplitude reflection coefficient for a-polarization and r, is the amplitude or flection coefficient for p-polarization

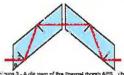
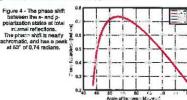


Figure 3 - A die gram of the Freshel rhomb APS, The beam undergoes 4 total-infernal -effections (TIR). At each TIR, a polarization-dependent rendration introduced in the beam. The acute prior angle



Design Process & Results

The design of both //PS derices was cest as an optimization problem: what selection of maturials and thicknesses achaives the achromatic phase shift white minimizing undesired efficient? The optimization procedure is complicated by the fact that one set of variation, the materials (for the glass plate 3 or coating is year), is discrete white after writishing, such as plate or coating layer thicknesses, are continuous. We used an in-house global several motion that generals, sonfigurations by selecting materials from a detailbase. These configurations are optimized by following several rejections through the coatch-space using a recursive branching structure. For each configuration that is tested, the continuous variables are optimized by a constrained nonlinuar optimization routine. We found this in-house routine to be significantly more efficient than a traditional global express which is soften as structure.

Table 1 and Figures 5-8 show the quarted design for the glass-plate APS. Figures 3 and 10 show the outnut during for the Freenet rhomb prismAPS.

Table 1 - Glars-Plain APS materials & plate thicknesses

Location	Material	Thickness (mm)
Arm 1	Chars S-TIM25	3.835
Arm 1	Ohara S-BSM26	5,199
Arm 1	Chars S-TIH4	9.395
Am 2	Ohera S-BSM28	3,519
Arm 2	Ohara S-TIH1	14.780
/rm 2	Vacuum	0.240

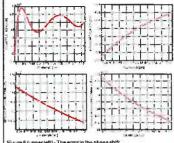


Figure 6 (upper left). The error in the phase shift, $[\Phi_{-}(\lambda)-\Phi_{-}(\lambda)]=\pi$. The mean error is -1.4 k·10* radians with a standard deviation of 4.70×10* radians.

Figure 6 (upper right) - The beam shear due to differential dispersion in each arm. The mean error is -50.05 µm with a standard deviation of 0.31 µm.

Figure 7 (lower left) - The differential transmitted intensity. The mean value is 1.24×10° percent with a standard deviation of 5.78×10°

Figure 8 (lower right) - The differential rotation of the polarization velor between the arms. The mean value is 3,98×10⁻⁹ radians and the standard deviation is 3.72×10⁻⁹ radians.

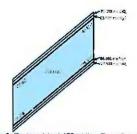


Figure 9 - The Linesel rhomb APS solution. The coating on each surface is identical, and consists of just two layers. All four prisms are identical.

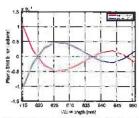


Figure 10 - The phase shift term ($\Phi_{\rm c}$ (A) - $\Phi_{\rm c}$ (A)) - $\pi_{\rm c}$ in each polarization state, he mean error for expolarization is 4,449 0° radiens with a standard deviation of 4,35×10° radiens. For p-polarization, the mean error is -1,24×10° radiens with a standard deviation of 4,35×10° radiens.